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High Contrast Metastructures X

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Contents

	PLANAR METASURFACE OPTICS I
11695 08	Ultra-high figure-of-merit dielectric metasurface [11695-4]
	ACTIVE METASTRUCTURES
11695 OP	Wide-angle beam focusing with a tuning GeSbTe phase-change metalens [11695-21]
11695 OU	Development of thick epsilon-near-zero ITO metafilms for use in metastructure and metasurface devices [11695-26]
	NOVEL RESONANT EFFECTS
11695 18	Bound states in the continuum in silicon integrated photonic devices [11695-40]
	METASURFACES AND IMAGING
11695 1G	Design and optimized fabrication techniques for highly-efficient dielectric meta-optical Airy beam generators [11695-48]
	POLARIZATION AND CHIRALITY
11695 1M	Chiroptical effect induced by achiral structures for full dimensional manipulation of optical waves [11695-54]
	HIGH CONTRAST GRATINGS
11695 1N	Suspended subwavelength gratings for optical processing and optomechanics (Invited Paper) [11695-55]
11695 1P	Silicon nitride based medium contrast gratings for generating longitudinally polarized resonant fields [11695-57]